

The GreenMOS<sup>®</sup>

at  $T_j=25^\circ\text{C}$  unless otherwise noted

Drain-source voltage	$V_{DS}$	550	V
Gate-source voltage	$V_{GS}$	$\pm 30$	V
Continuous drain current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_D$	11	A
Continuous drain current <sup>1)</sup> , $T_C=100^\circ\text{C}$		7	
Pulsed drain current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{D, pulse}$	33	A
Continuous diode forward current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_S$	11	A
Diode pulsed current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{S, pulse}$	33	A
Power dissipation <sup>3)</sup> , $T_C=25^\circ\text{C}$	$P_D$	63	W
Single pulsed avalanche energy <sup>5)</sup>	$E_{AS}$	200	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0\dots 480\text{ V}$	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS}=0\dots 480\text{ V}$ , $I_{SD} = I_D$	dv/dt	15	V/ns
Operation and storage temperature	$T_{stg}, T_j$	-55 to 150	$^\circ\text{C}$

Thermal resistance, junction-case	$R_{JC}$	1.98	$^\circ\text{C/W}$
Thermal resistance, junction-ambient <sup>4)</sup>	$R_{JA}$	62	$^\circ\text{C/W}$

 at  $T_j=25^\circ\text{C}$  unless otherwise specified

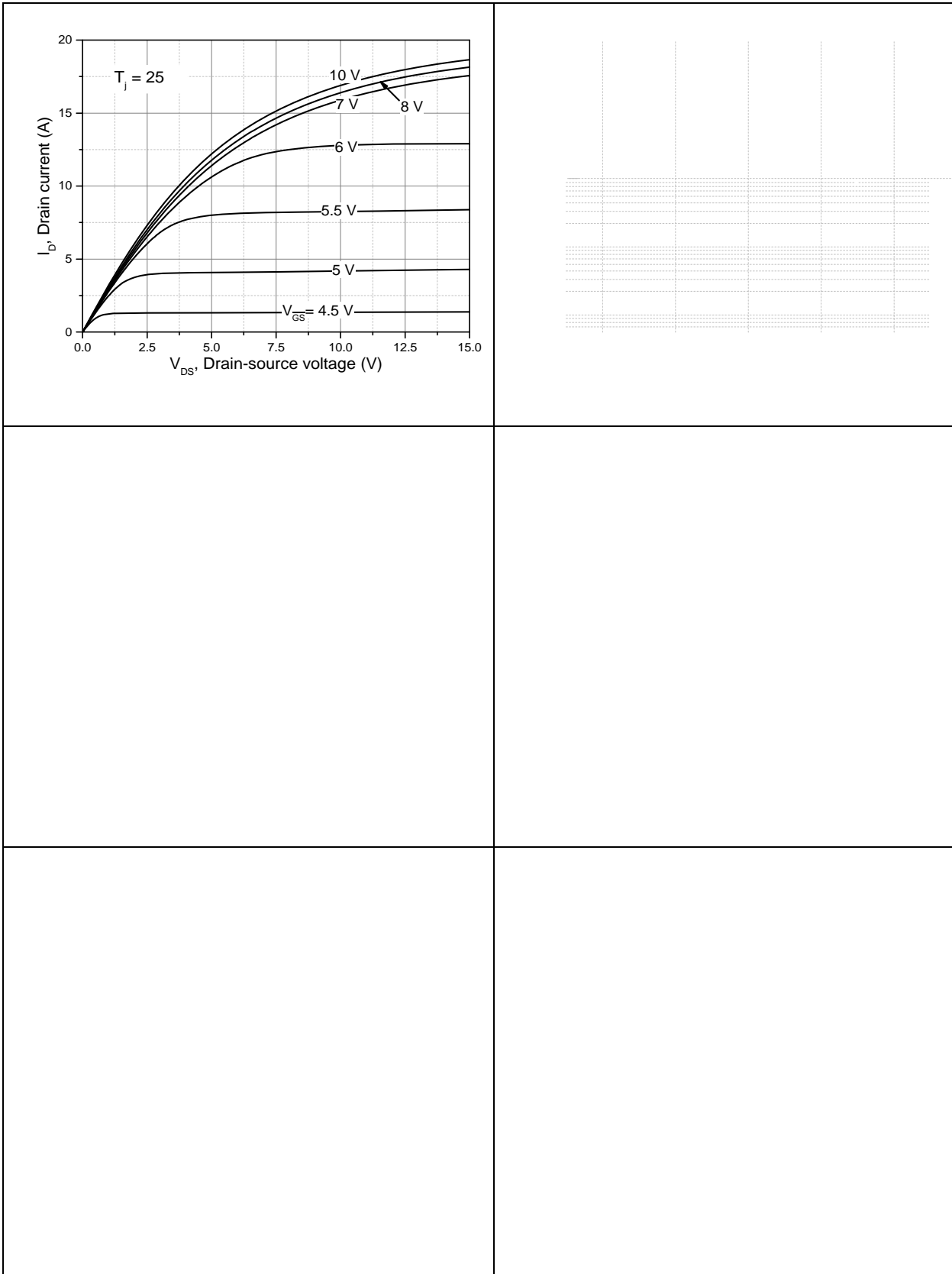
Drain-source breakdown voltage	$BV_{DSS}$	550			V	$V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$
		600				$V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}, T_j=150^\circ\text{C}$
Gate threshold voltage	$V_{GS(th)}$	2.0		4.0	V	$V_{DS}=V_{GS}, I_D=250\text{ }\mu\text{A}$
Drain-source on-state resistance	$R_{DS(ON)}$		0.30	0.38		$V_{GS}=10\text{ V}, I_D=5.5\text{ A}$
			0.79			$V_{GS}=10\text{ V}, I_D=5.5\text{ A}, T_j=150^\circ\text{C}$
Gate-source leakage current	$I_{GSS}$			100	nA	$V_{GS}=30\text{ V}$
				-100		$V_{GS}=-30\text{ V}$
Drain-source leakage current	$I_{DSS}$			1	$\mu\text{A}$	$V_{DS}=550\text{ V}, V_{GS}=0\text{ V}$

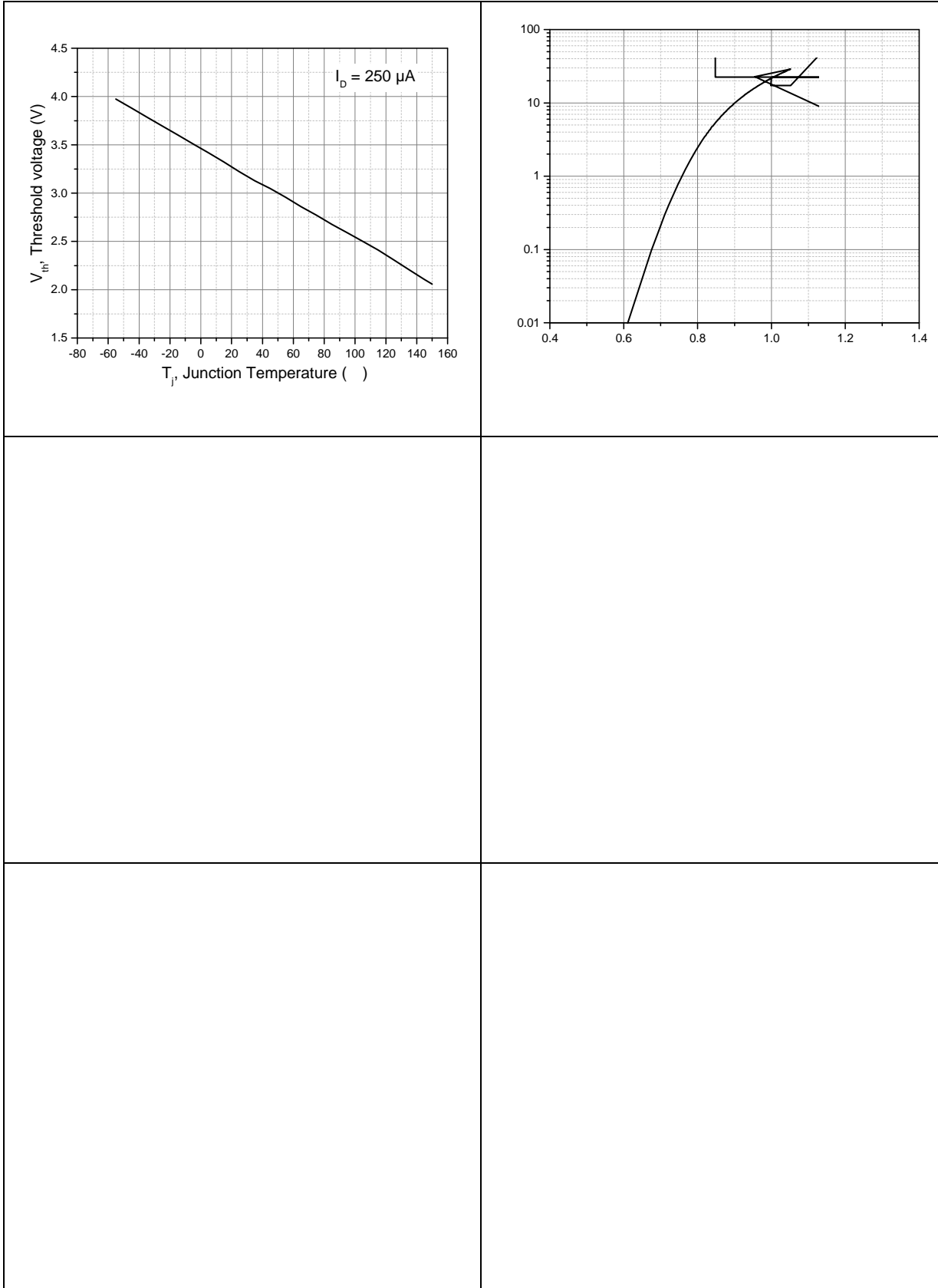
Input capacitance	$C_{iss}$	549.3	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=50\text{ V}$ , $f=1\text{ MHz}$
Output capacitance	$C_{oss}$	63.1	pF	
Reverse transfer capacitance	$C_{rss}$	2.1	pF	
Turn-on delay time	$t_{d(on)}$	28	ns	$V_{GS}=10\text{ V}$ , $V_{DS}=400\text{ V}$ , $R_G=2\ \Omega$ , $I_D=6\text{ A}$
Rise time	$t_r$	22.8	ns	
Turn-off delay time	$t_{d(off)}$	60.3	ns	
Fall time	$t_f$	18	ns	

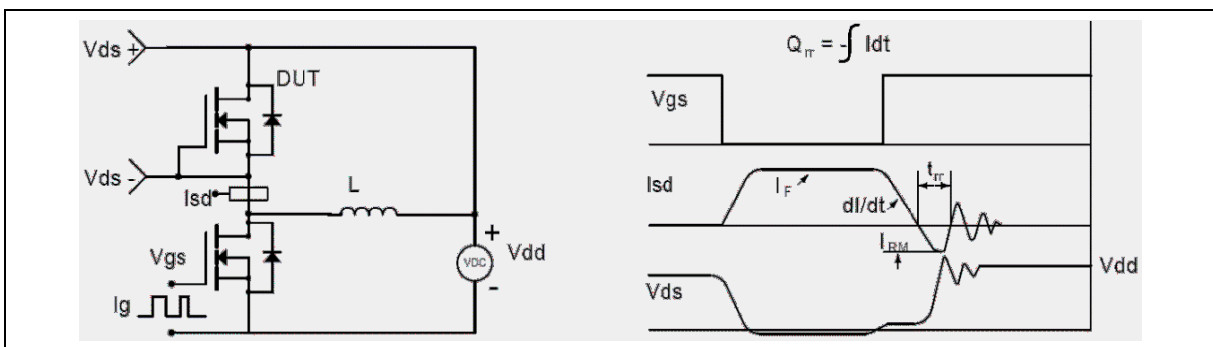
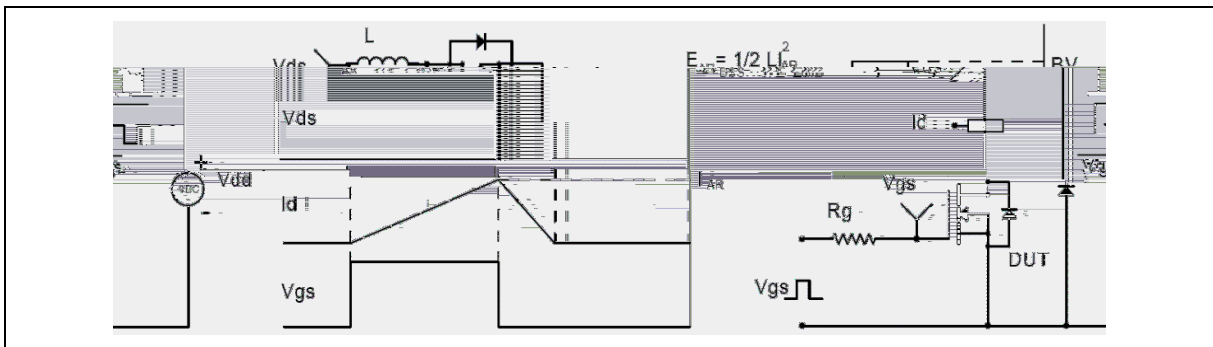
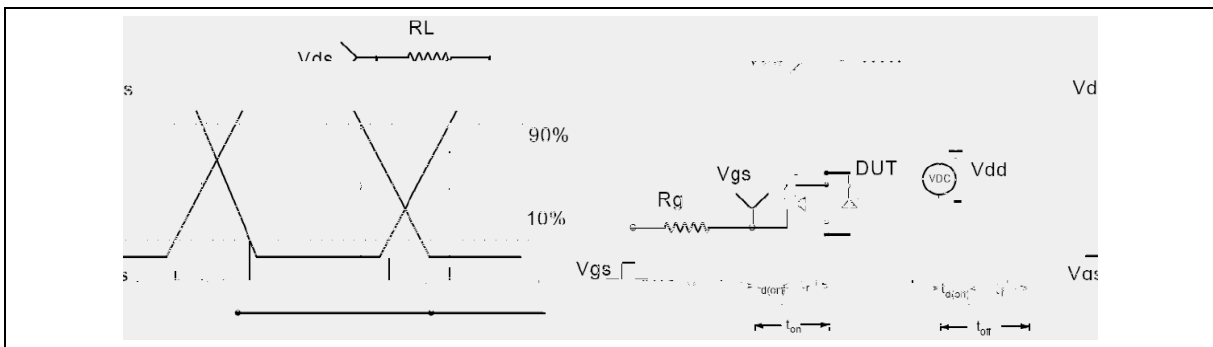
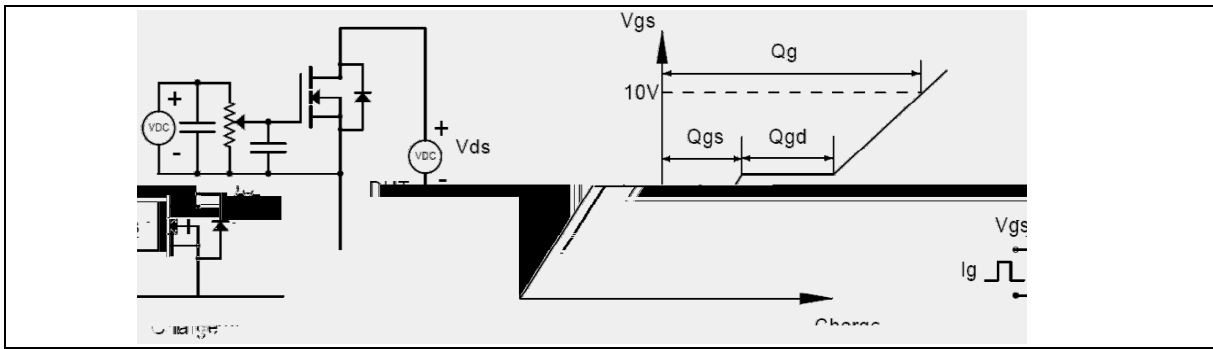
Total gate charge	$Q_g$	12.5	nC	$V_{GS}=10\text{ V}$ , $V_{DS}=400\text{ V}$ , $I_D=6\text{ A}$
Gate-source charge	$Q_{gs}$	2.6	nC	
Gate-drain charge	$Q_{gd}$	5.7	nC	
Gate plateau voltage	$V_{plateau}$	5.8	V	

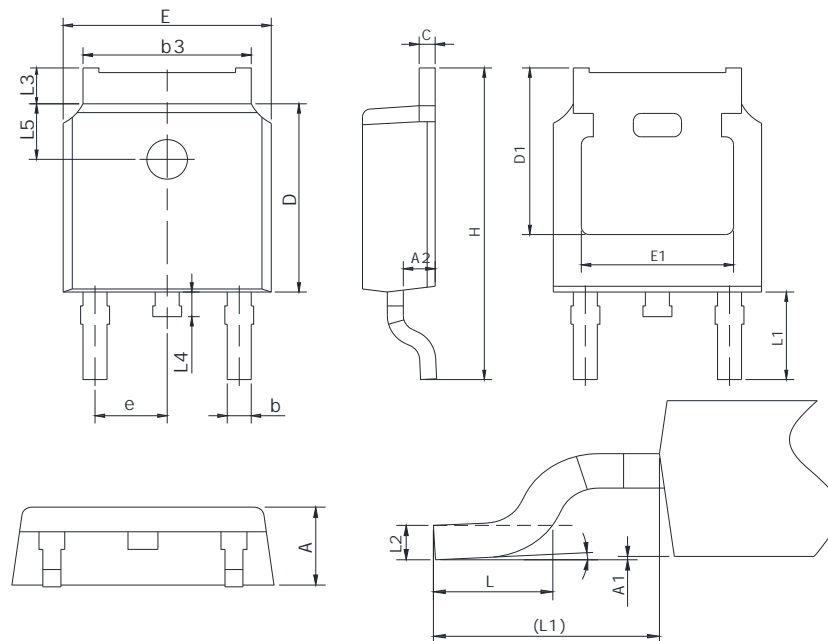
Diode forward voltage	$V_{SD}$	1.3	V	$I_S=11\text{ A}$ , $V_{GS}=0\text{ V}$
Reverse recovery time	$t_{rr}$	199	ns	$V_R=400\text{ V}$ , $I_S=6\text{ A}$ , $di/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	$Q_{rr}$	1.7	$\mu\text{C}$	
Peak reverse recovery current	$I_{rrm}$	17.4	A	

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3)  $P_d$  is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of  $R_{JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_a=25\text{ }^\circ\text{C}$ .
- 5)  $V_{DD}=100\text{ V}$ ,  $V_{GS}=10\text{ V}$ ,  $L=10\text{ mH}$ , starting  $T_j=25\text{ }^\circ\text{C}$ .



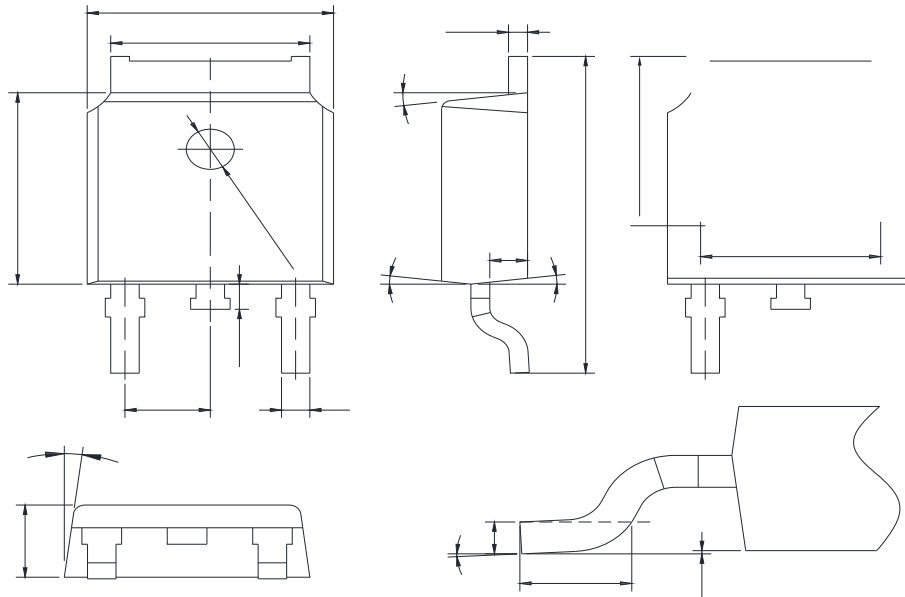






Symbol	mm		
	Min	Nom	Max
A	2.20	2.30	2.38
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.46
c	0.43	0.53	0.61
D	5.98	6.10	6.22
D1	5.30REF		
E	6.40	6.60	6.73
E1	4.63	-	-
e	2.286BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88	-	1.28
L4	0.50	-	1.00
	0°	-	8°

Version 1: TO252-C package outline dimension



Symbol	mm		
	Min	Nom	Max
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.90	1.01	1.10
b	0.72	-	0.85
b1	0.71	0.76	0.81
b2	0.72	-	0.90
b3	5.13	5.33	5.46
c	0.47	-	0.60
c1	0.46	0.51	0.56
c2	0.47	-	0.60
D	6.00	6.10	6.20
D1	5.25	-	-
E	6.50	6.60	6.70
E1	4.70	-	-
e	2.186	2.286	2.386
H	9.80	10.10	10.40
L	1.40	1.50	1.70
L1	2.90REF		
L2	0.508BSC		
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	0.15	-	0.75
L6	1.80REF		
	0°	-	8°
1	5°	7°	9°
2	5°	7°	9°

Version 2: TO252-J package outline dimension



TO252-C	2500	2	5000	5	25000
TO252-J	2500	2	5000	5	25000

OSG55R380DF	TO252	yes	yes	yes

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